

EMC Test Report

Report No.: AGC14435230901ER01

PRODUCT DESIGNATION : Smart Watch

BRAND NAME : Blackview, IOWODO, FeipuQu, Baolubao

X1_5, X1, X1Pro, W30, W50, W60, W70, W80, W90, **MODEL NAME**

W30Pro, W50Pro, W60Pro, W70Pro, W80Pro, W90Pro

APPLICANT : Shenzhen Hairuichuang Technology Co., Ltd.

DATE OF ISSUE : Sep. 21, 2023

ETSI EN 301 489-1 V2.2.3 (2019-11) STANDARD(S)

ETSI EN 301 489-17 V3.2.4 (2020-09)

REPORT VERSION : V1.0

> ce (Shenzhen) Co., Ltd Attestation of Global



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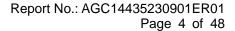
REPORT REVISE RECORD

Report Version	Revise Time	Issued Date	Valid Version	Notes
V1.0	/	Sep. 21, 2023	Valid	Initial release



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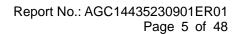
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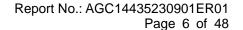
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16.2. TEST PROCEDURE Any report having not been signed by authorized approver, or having been altered without authorization, or having not been stamped by the "Dedicate Stamp" is deemed to be invalid. Copying or excerpting portion of, or altering the content of the report is not permitted without the written authorization presented in the report apply only to the tested sample. Any objections to report issued by AGC should be submitted to AGC within 15days after the issued by AGC should be submitted to AGC within 15days after the issued by AGC should be submitted to AGC within 15days after the issued by AGC should be submitted to AGC within 15days after the issued by AGC should be submitted to AGC within 15days after the issued by AGC should be submitted to AGC within 15days after the issued by AGC should be submitted to AGC within 15days after the issued by AGC should be submitted to AGC within 15days after the issued by AGC should be submitted to AGC within 15days after the issued by AGC should be submitted by AGC should be subm	ed Testing/Inspection of AGC. The test results

Further enquiry of validity or verification of the test report should be addressed to AGC by agc01@agccert.com.





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1. TEST REPORT CERTIFICATION

Shenzhen Hairuichuang Technology Co., Ltd.	
Room 2001, Building A, Weidonglong Business Building, No. 2125, Meilong Avenue, Longhua District, Shenzhen, China	
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Shenzhen Hairuichuang Technology Co., Ltd.	
Room 2001, Building A, Weidonglong Business Building, No. 2125, Meilong Avenue, Longhua District, Shenzhen, China	
Smart Watch	
Blackview, IOWODO, FeipuQu, Baolubao	
X1_5	
X1, X1Pro, W30, W50, W60, W70, W80, W90, W30Pro, W50Pro, W60Pro, W70Pro, W80Pro, W90Pro	
All the same except for the model names.	
Sep. 11, 2023	
Sep. 11, 2023 to Sep. 21, 2023	
None	
Normal	
Pass	
AGCRT-EC-EMC	

Note: The test results of this report relate only to the tested sample identified in this report.

Prepared By	Cocili	
	Cici Li (Project Engineer)	Sep. 21, 2023
Reviewed By	Calin Liu	
	Calvin Liu (Reviewer)	Sep. 21, 2023
Approved By	Max Zhang	
	Max Zhang Authorized Officer	Sep. 21, 2023



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2. GENERAL INFORMATION

2.1. DESCRIPTION OF EUT

The EUT is a short range, lower power, Bluetooth device.

Details of technical specification refer to the description in follows:

Transmitter/Receiver (TX/RX)

Tansmitter/Receiver (TX/RX)			
Operating Frequency	2402MHz to 2480MHz		
Bluetooth Version	V5.3		
IMOGUIATION LYDE	BR ⊠GFSK 1Mbps; EDR ⊠π /4-DQPSK 2Mbps ⊠8DPSK 3Mbps BLE ⊠GFSK 1Mbps ⊠GFSK 2Mbps		
Number of channels	79 Channels for BR/EDR		
Number of Chamiles	40 Channels for BLE		
Hardware Version	V1.0		
Software Version	V1.0		
Antenna Type	FPC Antenna		
Antenna Gain	1.29dBi		
Power Supply DC 3.8V by battery or DC 5V by adapter			

2.2. OBJECTIVE

Perform Electro Magnetic Interference (EMI) and Electro Magnetic Susceptibility (EMS) tests for CE Marking.

2.3. TEST STANDARDS AND RESULTS

The EUT has been tested according to ETSI EN 301 489-1 V2.2.3 (2019-11) and ETSI EN 301 489-17 V3.2.4 (2020-09).

	ElectroMagnetic Compatibility (EMC) standard for radio equipment and services; Part	
ETSI EN 301 489-1	1: Common technical requirements; Harmonised Standard for ElectroMagnetic	
	Compatibility.	
	ElectroMagnetic Compatibility (EMC) standard for radio equipment and services;	
ETSI EN 301 489-17	Part 17: Specific conditions for Broadband Data Transmission Systems;	
	Harmonised Standard for ElectroMagnetic Compatibility	



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2.4. TEST ITEMS AND THE RESULTS

No.	Basic Standard	Test Type	Result	
EMIS	EMISSION (EN 301 489-1 §7.1)			
1	EN 55032	Radiated emission	PASS	
2	EN 55032	Conducted emission, AC ports	PASS	
3	EN 55032	Conducted emission, Telecom ports	N/A	
4	EN 61000-3-2	Harmonic current emissions	PASS	
5	EN 61000-3-3	Voltage fluctuations & flicker	PASS	
IMM	IMMUNITY (EN 301 489-1 §7.2)			
6	EN 61000-4-2	Electrostatic discharge immunity	PASS	
7	EN 61000-4-3	Radiated RF electromagnetic field immunity	PASS	
8	EN 61000-4-4	Electrical fast transient/burst immunity	PASS	
9	ISO 7637-1, -2	Transients and surges, DC ports	N/A	
10	EN 61000-4-5	Surge immunity, AC ports, Telecom ports	PASS	
11	EN 61000-4-6	Immunity to conducted disturbances induced by RF fields	PASS	
12	EN 61000-4-11	Voltage dips and short interruptions immunity	PASS	

Note: 1. N/A- Not Applicable.

2. The latest versions of basic standards are applied.

2.5. ENVIRONMENTAL CONDITIONS

During the measurement the environmental conditions were within the listed ranges:

Temperature: 15-35°CRelative humidity: 30-60%

- Atmospheric pressure: 86-106kPa



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3. TEST MODE DESCRIPTION

TEST MODE DESCRIPTION			
NO.	EMI TEST MODE DESCRIPTION	WORST	
1	BT mode with charging	-	
2	BLE mode with charging		
3	BT mode		
4	BLE mode		
NO.	EMS TEST MODE DESCRIPTION	WORST	
1	BT mode with charging		
2	BLE mode with charging		
3	BT mode		
4	BLE mode		
Note: 1. All modes have been tested and only the worst mode test data recorded in the test report.			

I/O Port Information (⊠Applicable □Not Applicable)

I/O Port of EUT			
I/O Port Type Number Cable Description Tested With			
DC IN	1	0.6m unshielded	1



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4. MEASUREMENT UNCERTAINTY

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in measurement" (GUM) published by CISPR and ANSI.

- Uncertainty of Conducted Emission, Uc = ±2.9 dB
- Uncertainty of Radiated Emission below 1GHz, Uc = ±3.9 dB
- Uncertainty of Radiated Emission above 1GHz, Uc = ±4.9 dB

5. SUPPORT EQUIPMENT

Device Type	Manufacturer	Model Name	Data Cable
Adapter	jinbaotong	K-T10E0502000E	
Xiaomi phone	Xiaomi	Mi 10	

Note: 1. "-- "means no any support device during testing.



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6. IDENTIFICATION OF THE RESPONSIBLE TESTING LOCATION

Site	Attestation of Global Compliance (Shenzhen) Co., Ltd
Location	1-2/F, Building 19, Junfeng Industrial Park, Chongqing Road, Heping Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China

TEST EQUIPMENT OF CONDUCTED EMISSION TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Test Receiver	R&S	ESPI	101206	Jun. 03, 2023	Jun. 02, 2024
Artificial power network	R&S	ESH2-Z5	100086	Jun. 03, 2023	Jun. 02, 2024
Test software	R&S	ES-K1	Ver.V1.7.1	N/A	N/A

TEST EQUIPMENT OF RADIATED EMISSION TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Test Receiver	R&S	ESCI	10096	Feb. 18, 2023	Feb. 17, 2024
EXA Signal Analyzer	Aglient	N9010A	MY53470504	Jun. 01, 2023	May 31, 2024
Double-Ridged Waveguide Horn	ETS LINDGREN	3117	00034609 Mar. 23, 2023		Mar. 22, 2024
Preamplifier Assembly	ETS	3117PA	00225134	00225134 Sep. 02, 2022	
Wideband Antenna	SCHWARZBEC K	VULB9168	VULB9168-49 4	Jan. 05, 2023	Jan. 04, 2025
Test Software	FARA	EZ-EMC(Ver.RA- 03A)	N/A	N/A	N/A
Test Software	Tonscend	JS32-RE(Ver.2.5)	N/A	N/A	N/A

TEST EQUIPMENT OF POWER HARMONICS / VOLTAGE FLUCTUATION / FLICKER TEST

Equipment	Manufacturer Model S/N		S/N	Cal. Date	Cal. Due
Signal Conditioning Unit	Schaffner	CCN1000-1	72431	Jun. 08, 2023	Jun. 07, 2024
AC Source	Schaffner	NSG1007	56825	Jun. 02, 2023	Jun. 01, 2024
Test software	TESEQ	4.29.0	N/A	N/A	N/A

TEST EQUIPMENT OF ESD TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
ESD Simulator	Schaffner	NSG 438	782	Dec. 30, 2022	Dec. 29, 2023



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TEST EQUIPMENT OF SURGE/EFT/DIPS TEST

Equipment	Manufacturer	Model S/N		Cal. Date	Cal. Due	
EFT/Surge Generator	Schaffner	Modula 6150	34437	Jun. 08, 2023	Jun. 07, 2024	
Test software	TESEQ	2.31	N/A	N/A	N/A	

TEST EQUIPMENT OF RS IMMUNITY TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Signal Generator	Aglient	N5182A	MY50140530	Feb. 17, 2023	Feb. 16, 2024
Directional coupler	Werlatone	C5571-10	99463	Mar. 10, 2022	Mar. 09, 2024
Directional coupler	Werlatone	C5571-10	99482	Mar. 10, 2022	Mar. 09, 2024
Power Meter	R&S	NRVD	8323781027	Mar. 24, 2022	Mar. 23, 2025
Power Amplifier	KALMUS	7100LC	04-02/17-06-001	N/A	N/A
Power Amplifier	Milmega	AS0104-55_55	1004793	N/A	N/A
Power amplifer	rflight	NTWPA-256010 0	17063183	N/A	N/A
Biconilog Antenna	ETS	3142C	00060447	N/A	N/A
Broadband high gain horn antenna	SCHWARZBEC K	BBHA 9120 J	00073	N/A	N/A
Test Software	Tonscend	2.0.1.8	N/A	N/A	N/A

TEST EQUIPMENT OF CS IMMUNITY TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due	
Power Amplifier	AR	75A250	18464	N/A	N/A	
CDN	ZHINAN	ZN3751	15004	Aug. 03, 2022	Sep. 02, 2024	
6dB attenuator	ZHINAN	E-002 N/A		Aug. 04, 2022	Aug. 03, 2024	
Power Probe	R&S	URV5-Z4 100124 Mar. 24, 202		Mar. 24, 2023	Mar. 23, 2025	
Electromagnetic Injection Clamp	Luthi	EM101	35773	Aug. 12, 2022	Aug. 11, 2024	
Power Meter	R&S	NRVD	8323781027	Mar. 24, 2023	Mar. 23, 2025	
Signal Generator	Aglient	E4421B	MY43351603	Feb. 17, 2023	Feb. 16, 2024	
Test Software	Tonscend	2.0.1.8 N/A N/A		N/A		



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7. RADIATED DISTURBANCE MEASUREMENT

7.1. LIMITS OF RADIATED DISTURBANCES

Limits for radiated disturbance 30M to1 GHz at a measurement distance of 3m

Frequency range (MHz)	Quasi peak limits(dBuV/m), for Class B ITE, at 3m measurement distance
30-230	40
230-1000	47

Limits for radiated disturbance above 1 GHz at a measurement distance of 3m

Fraguency range (MUT)	Limits (dBuV/m), Class B ITE				
Frequency range (MHz)	Peak	Average			
1000-3000	70	50			
3000-6000	74	54			

Note: 1. The lower limit shall apply at the transition frequency.

2. Additional provisions may be required for cases where interference occurs.

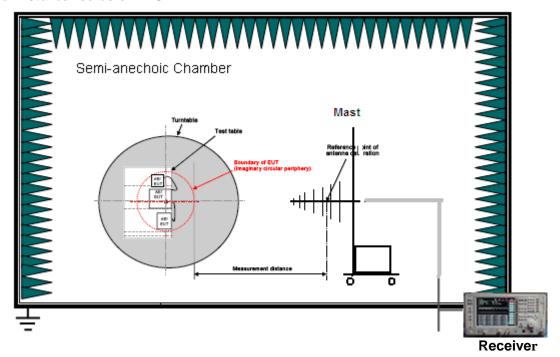
7.2. TEST PROCEDURE

- (1). The EUT was placed on the top of an insulating table 0.8 meters above the ground at a semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- (2). The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- (3). The antenna is a broadband antenna, and its height is varied from 1 to 4 meter above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- (4). For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to the heights from 1 to 4 meters and the ratable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- (5). The test-receiver system was set to Peak Detector Function and Specified Bandwidth with Maximum Hold Mode. If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emission that did not have 10dB margin would be retested one by one using the quasi-peak method.

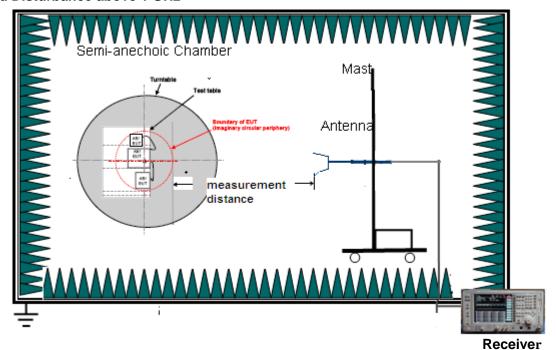


7.3. BLOCK DIAGRAM OF TEST SETUP

Radiated Disturbance below 1 GHz



Radiated Disturbance above 1 GHz



For the actual test configuration, please refer to the related item-Photographs of the Test Configuration.

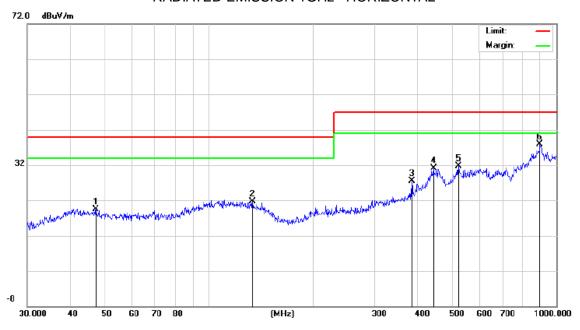


7.4. TEST RESULT

The test modes were carried out for all modes.

The worst test mode of the EUT was Mode 3, and its test data was showed as the follow:

RADIATED EMISSION 1GHz-HORIZONTAL

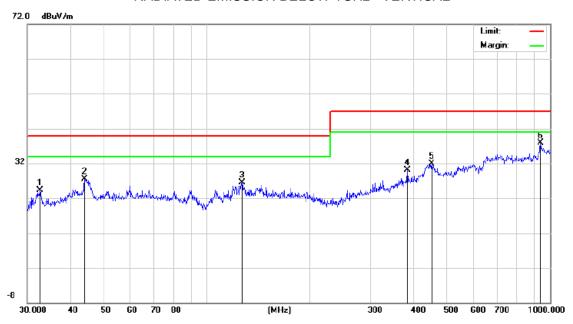


No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dΒ	dBuV/m	dB/m	dΒ	Detector
1		47.3255	6.14	13.39	19.53	40.00	-20.47	peak
2		133.6188	6.16	15.58	21.74	40.00	-18.26	peak
3		383.9318	8.82	18.63	27.45	47.00	-19.55	peak
4		443.2943	6.09	24.98	31.07	47.00	-15.93	peak
5		522.7180	6.76	25.02	31.78	47.00	-15.22	peak
6	*	896.9965	6.58	31.42	38.00	47.00	-9.00	peak

RESULT: PASS

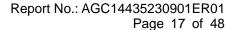


RADIATED EMISSION BELOW 1GHz- VERTICAL



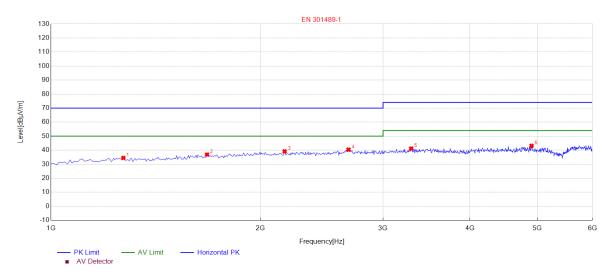
No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dB/m	dΒ	Detector
1		32.7486	9.74	14.51	24.25	40.00	-15.75	peak
2		44.1202	10.47	16.94	27.41	40.00	-12.59	peak
3	1	26.7723	8.67	17.87	26.54	40.00	-13.46	peak
4	3	383.9318	8.49	21.56	30.05	47.00	-16.95	peak
5	4	152.7197	6.38	25.53	31.91	47.00	-15.09	peak
6	* 6	338.8326	7.14	30.84	37.98	47.00	-9.02	peak

RESULT: PASS





RADIATED EMISSION ABOVE 1GHz - HORIZONTAL

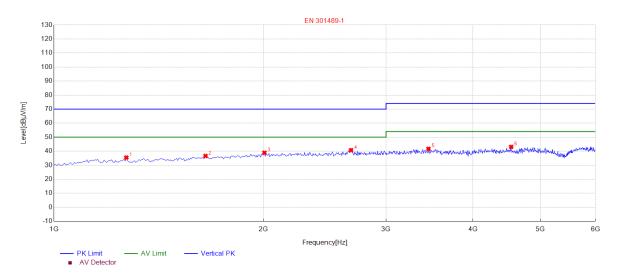


PK D	ata List							
NO	Freq.	Level	Factor	Limit	Margin	Height	Angle	Dolovitu
NO.	[MHz]	[dBµV/m]	[dB]	[dBµV/m]	[dB]	[cm]	[°]	Polarity
1	1270.2703	34.50	-17.72	70.00	35.50	100	230	Horizontal
2	1675.6757	36.89	-15.87	70.00	33.11	100	350	Horizontal
3	2166.1662	39.20	-13.19	70.00	30.80	100	290	Horizontal
4	2676.6767	40.41	-12.30	70.00	29.59	100	110	Horizontal
5	3292.2923	41.20	-11.35	74.00	32.80	100	170	Horizontal
6	4903.9039	43.13	-7.89	74.00	30.87	100	150	Horizontal

RESULT: PASS



RADIATED EMISSION ABOVE 1GHz - VERTICAL



PK D	ata List							
NO	Freq.	Level	Factor	Limit	Margin	Height	Angle	Dolovitu
NO.	[MHz]	[dBµV/m]	[dB]	[dBµV/m]	[dB]	[cm]	[°]	Polarity
1	1270.2703	35.47	-17.72	70.00	34.53	100	90	Vertical
2	1650.6507	36.64	-16.04	70.00	33.36	100	90	Vertical
3	2006.006	38.91	-13.56	70.00	31.09	100	290	Vertical
4	2671.6717	40.76	-12.30	70.00	29.24	100	190	Vertical
5	3452.4525	41.70	-10.96	74.00	32.30	100	30	Vertical
6	4538.5385	43.12	-7.94	74.00	30.88	100	80	Vertical

RESULT: PASS



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8. CONDUCTED EMISSION MEASUREMENT

8.1. LIMITS OF LINE CONDUCTED EMISSION

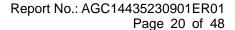
Fraguency range (MUT)	Limits (dBuV) Class B ITE			
Frequency range (MHz)	Quasi-peak	Average		
0.15-0.50	66 to 56	56 to 46		
0.50-5	56	46		
5-30	60	50		

Note: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.

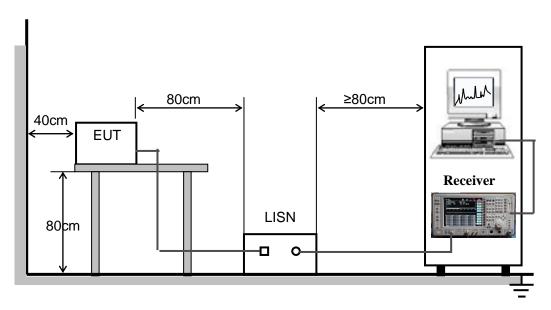
8.2. TEST PROCEDURE

- (1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55032 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- (2) Support equipment, if needed, was placed as per EN 55032.
- (3) All I/O cables were positioned to simulate typical actual usage as per EN 55032.
- (4) The EUT received DC 5V power from adapter which received AC 230V 50Hz power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.
- (5) The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the AN powering the EUT. The AN has two monitoring points: Line 1 (Positive) and Line 2 (Negative). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
- (6) Analyzer / Receiver scanned from 150 kHz to 30 MHz for emissions in each of the test modes.
- (7) During the above scans, the emissions were maximized by cable manipulation.
- (8) A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions.
- (9) Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less –2dB to the A.V. limit in Peak mode, then the emission signal was re-checked using Q.P and Average detector.





8.3. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

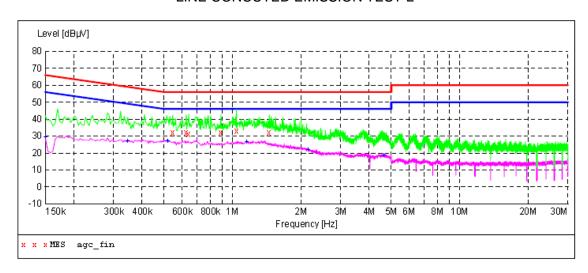


8.4. TEST RESULT

The test modes were carried out for mode1 and mode2.

The worst test mode of the EUT was Mode 1, and its test data was showed as the follow:

LINE CONCUTED EMISSION TEST-L



MEASUREMENT RESULT: "agc fin"

2023/9/19 13:55

.023/ // 17 13						
Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line
0.546000	32.10	6.2	56	23.9	QP	L1
0.626000	32.10	6.2	56	23.9	QP	L1
0.642000	31.30	6.2	56	24.7	QP	L1
0.890000	32.00	6.2	56	24.0	QP	L1
1.042000	33.10	6.2	56	22.9	QP	L1
1.454000	32.20	6.2	56	23.8	QP	L1

MEASUREMENT RESULT: "agc fin2"

2023/9/19 13:55

Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line
0.150000	29.50	6.1	56	26.5	AV	L1
0.346000	26.80	6.1	49	22.3	AV	L1
0.518000	26.80	6.2	46	19.2	AV	L1
1.158000	26.30	6.2	46	19.7	AV	L1
2.150000	22.00	6.2	46	24.0	AV	L1
4.646000	18.50	6.3	46	27.5	AV	L1

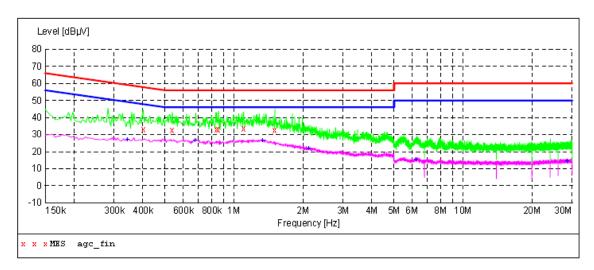
RESULT: PASS

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LINE CONCUTED EMISSION TEST-N



MEASUREMENT RESULT: "agc fin"

2023/9/19 13:51

23/3/13 13:	J T					
Frequency	Level	Transd	Limit	_	Detector	Line
MHz	dΒμV	dB	dΒμV	dB		
0.402000	33.10	6.1	58	24.7	QP	N
0.538000	32.60	6.2	56	23.4	QP	N
0.842000	33.00	6.2	56	23.0	QP	N
0.858000	32.80	6.2	56	23.2	QP	N
1.102000	33.70	6.2	56	22.3	QP	N
1.510000	32.40	6.2	56	23.6	QP	N

MEASUREMENT RESULT: "agc fin2"

2023/9/19 13:51

.023/ // 17 13						
Frequency	Level	Transd	Limit	Margin	Detector	Line
MHz	dΒμV	dB	dΒμV	dB		
0.342000	26.80	6.1	49	22.4	AV	N
0.678000	26.60	6.2	46	19.4	AV	N
1.330000	26.60	6.2	46	19.4	AV	N
2.126000	21.90	6.2	46	24.1	AV	N
6.210000	15.30	6.5	50	34.7	AV	N
28.526000	14.40	8.2	50	35.6	AV	N

RESULT: PASS



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9. HARMONIC CURRENT MEASUREMENT

9.1. LIMITS OF HARMONIC CURRENT

Limits fo	Limits for Class A Equipment						
Harmonics Order n	Max. permissible harmonic current (A)						
O	Odd harmonics						
3	2.30						
5	1.14						
7	0.77						
9	0.40						
11	0.33						
13	0.21						
15≤n≤39	0.15×15/n						
Ev	en harmonics						
2	1.08						
4	0.43						
6	0.30						
8≤n≤40	0.23×8/n						

Note: 1. According to section 5 of EN 61000-3-2: 2014, the EUT is Class A equipment.

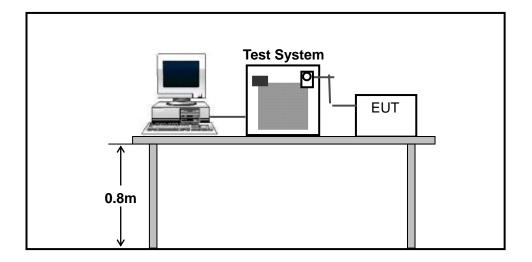
2. The above limits are for all applications having an active input power>75W. No limits apply for equipment with an active input power up to and including 75W.

9.2. TEST PROCEDURE

- 1. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- 2. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the necessary for the EUT to be exercised.



9.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.

9.4. TEST RESULT

Note: Equipment with a rated power less than or equal to 75W is deemed to fulfil all relevant requirements of this standard without testing.



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10. VOLTAGE FLUCTUATIONS AND FLICK MEASUREMENT

10.1. LIMITS OF VOLTAGE FLUCTUATIONS AND FLICK

Test Item Limit		Note
P _{st}	1.0	P _{st} means Short-term flicker indicator
P _{lt}	0.65	P _{lt} means long-term flicker indicator
T _{dt}	0.5	T _{dt} means maximum time that d _t exceeds 3%
d _{max} (%)	4%	d _{max} means maximum relative voltage change.
d _c (%)	3.3%	d _c means relative steady-state voltage change.

10.2. TEST PROCEDURE

- 1. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal conditions
- 2. During the flick measurement, the measure time shall include that part of whole operation changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

10.3. TEST SETUP

Same as 9.3

10.4. TEST RESULT

Test Specification

Test Frequency	50Hz	Test Voltage	230V AC
Waveform	Sine	Test Time	10 minutes(P _{st}); 2 hours (P _{lt})

Test Result

Test Parameter	Measurement Value	Limit	Remarks
P _{st}	0.248	1.0	Pass
P _{lt}	0.108	0.65	Pass
$T_{dt(s)}$	0.0	0.5	Pass
d _{max} (%)	0.00	4%	Pass
d _c (%)	0.00	3.3%	Pass



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11. IMMUNITY TEST

11.1. DESCRIPTION OF PERFORMANCE CRITERIA

The performance criteria are used to take a decision on whether a radio equipment passes or fails immunity tests.

For the purpose of the present document two categories of performance criteria apply:

- Performance criteria for continuous phenomena.
- Performance criteria for transient phenomena.

11.2. GENERAL PERFORMANCE CRITERIA

1. Performance criteria for continuous phenomena

During the test, the equipment shall:

- · continue to operate as intended;
- · not unintentionally transmit;
- not unintentionally change its operating state;
- · not unintentionally change critical stored data.

2. Performance criteria for transient phenomena

For all ports and transient phenomena with the exception described below, the following applies:

- The application of the transient phenomena shall not result in a change of the mode of operation (e.g. unintended transmission) or the loss of critical stored data.
- After application of the transient phenomena, the equipment shall operate as intended.

For surges applied to symmetrically operated wired network ports intended to be connected directly to outdoor lines the following criteria applies:

- For products with only one symmetrical port intended for connection to outdoor lines, loss of function is allowed, provided the function is self-recoverable, or can be otherwise restored. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.
- For products with more than one symmetrical port intended for connection to outdoor lines, loss of function on the port under test is allowed, provided the function is self-recoverable. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

For a 0 % residual voltage dip tests the following performance criteria apply:

• The performance criteria for transient phenomena shall apply.

For a 70 % residual voltage dip and voltage interruption tests, the following performance criteria apply:

- in the case where the equipment is fitted with or connected to a battery back-up, the performance criteria for transient phenomena shall apply;
- in the case where the equipment is powered solely from the AC mains supply (without the use of a parallel battery back-up) volatile user data may have been lost and if applicable the communication link need not to be maintained and lost functions should be recoverable by user or operator;
- no unintentional responses shall occur at the end of the test, when the voltage is restored to nominal;
- in the event of loss of function(s) or in the event of loss of user stored data, this fact shall be recorded.



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3. Performance Table

	EN 301 489-17 Performance criteria						
Criteria	During Test	After Test (i.e. as a result of the application of the test)					
А	Shall operate as intended. (see note). Shall be no loss of function. Shall be no unintentional transmissions.	Shall operate as intended. Shall be no degradation of performance. Shall be no loss of function. Shall be no loss of critical stored data.					
В	May be loss of function.	Functions shall be self-recoverable. Shall operate as intended after recovering. Shall be no loss of critical stored data.					
С	May be loss of function.	Functions shall be recoverable by the operator. Shall operate as intended after recovering. Shall be no loss of critical stored data.					

The performance criteria A shall apply for continuous phenomena.

The performance criteria B shall apply for transient phenomena, except for voltage dips greater than or equal to 100 ms and voltage interruptions of 5 000 ms duration, for which performance criteria C shall apply.

Where the EUT is a transmitter in standby mode or receive mode, unintentional transmission shall not occur during the test.

Note: Operate as intended during the test allows a level of degradation in accordance with the Minimum performance level.

Minimum performance level

For equipment that supports a PER or FER, the minimum performance level shall be a PER or FER less than or equal to 10 %.

For equipment that does not support a PER or a FER, the minimum performance level shall be no loss of the wireless transmission function needed for the intended use of the equipment.



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12. ELECTROSTATIC DISCHARGE IMMUNITY TEST

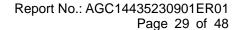
12.1 TEST SPECIFICATION

Basic Standard	EN 61000-4-2	
Discharge Impedance	330Ω / 150 pF	
Discharge Voltage	Air Discharge ±8kV, Contact Discharge ±4kV	
Polarity	Positive / Negative	
Number of Discharge	Minimum 25 times at each test point	
Discharge Mode	Single discharge	
Discharge Period	1-second minimum	

12.2 TEST PROCEDURE

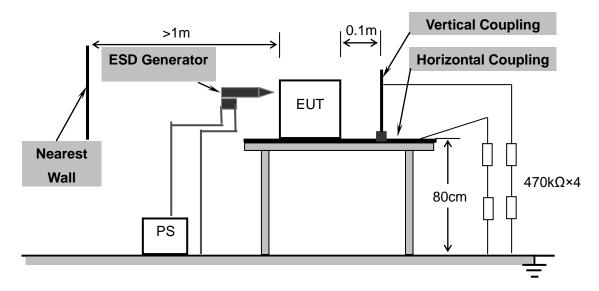
The test procedure was in accordance with EN 61000-4-2:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were completed.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned vertically at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m×0.5m) was placed vertically to and 0.1 meters from the EUT.





12.3 TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



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ESD LOCATION:

Blue line: Air discharge Red line: Contact discharge







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12.4 TEST RESULT

Times of Discharge	Voltage	Coupling	Test Mode	Performance criteria
Mini 25 / Point	±2kV; ±4kV	Contact discharge	Mode 1/2/3/4	А
Mini 25 / Point	±2kV; ±4kV; ±8kV	Air Discharge	Mode 1/2/3/4	А
Mini 25 / Point	±4kV	Indirect Discharge HCP	Mode 1/2/3/4	А
Mini 25 / Point	±4kV	Indirect Discharge VCP	Mode 1/2/3/4	А
A: No degradation in the performance of the EUT was observed.				

Note: operating mode include all modes of EMS in page 9.

12.5 PERFORMANCE

⊠Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
	e

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Stamp" is deemed to be invalid. Copying or excerpting portion of, or altering the content of the report is not permitted without the written authorization of AGC. The test res	ults
presented in the report apply only to the tested sample. Any objections to report issued by AGC should be submitted to AGC within 15days after the issuance of the test rep	ort.
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13. RADIATED, RADIO FREQUENCY ELECTROMAGNETIC FIELD IMMUNITY TEST 13.1. TEST SPECIFICATION

13.11. TEGT OF EOII TOATIC	514		
Basic Standard	EN 61000-4-3		
Frequency Range	80 MHz – 6000MHzMHz		
Field Strength	3V/m		
Modulation	1 kHz sine wave, 80%, AM modulation		
Frequency Step	1% of fundamental		
Polarity of Antenna	Horizontal and Vertical		
Test Distance	3m		
Antenna Height	1.55m		
Dwell Time	3 seconds		

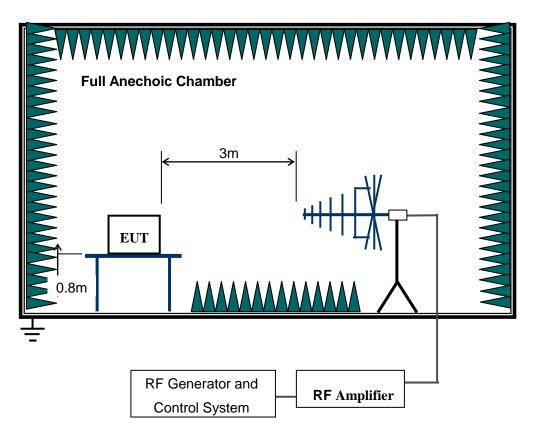
13.2. TEST PROCEDURE

The test procedure was in accordance with EN 61000-4-3.

- a. The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- b. The test signal was 80% amplitude modulated with a 1 kHz sine wave.
- c. The frequency range was swept from 80 MHz to 6000MHz with the exception of the exclusion band for transmitters, receivers and duplex transceivers. The rate of sweep did not exceed 1.5×10⁻³ decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- d. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- e. The field strength level was 3V/m.
- f. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



13.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



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13.4. TEST RESULT

Freq. Range (MHz)	Field	Modulation	Polarity	Position	Test Mode	Performance criteria
80-6000	3V/m	Yes	Н	Front	Mode 1/2/3/4	А
80-6000	3V/m	Yes	Н	Back	Mode 1/2/3/4	А
80-6000	3V/m	Yes	Н	Left	Mode 1/2/3/4	А
80-6000	3V/m	Yes	Н	Right	Mode 1/2/3/4	А
80-6000	3V/m	Yes	V	Front	Mode 1/2/3/4	А
80-6000	3V/m	Yes	V	Back	Mode 1/2/3/4	А
80-6000	3V/m	Yes	V	Left	Mode 1/2/3/4	А
80-6000	3V/m	Yes	V	Right	Mode 1/2/3/4	А

A: No degradation or PER < 10% in the performance of the EUT was observed.

Note: operating mode include all modes of EMS in page 9.

13.5. PERFORMANCE

⊠Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
	☐ Not Compliance
· ·	·



14. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

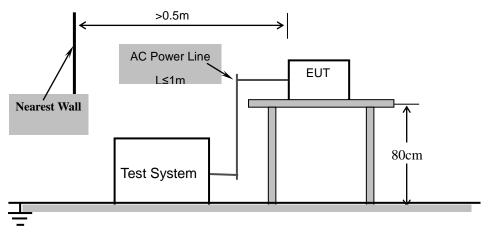
14.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-4	
Test Voltage	a.c. power port – 1 kV	
Polarity	Positive/Negative	
Impulse Frequency	equency 5kHz	
Impulse wave shape	5/50ns	
Burst Duration	15ms	
Burst Period	300ms	
Test Duration	Not less than 1 min.	

14.2. TEST PROCEDURE

- 1. The EUT was tested with 1000 volt discharges to the AC power input leads.
- 2. Both positive and negative polarity discharges were applied.
- 3. The length of the "hot wire" from the coaxial output of the EFT generator to the terminals on the EUT should not exceed 1 meter.
- 4. The duration time of each test sequential was 1 minute.
- 5. The transient/burst waveform was in accordance with IEC 61000-4-4, 5/50ns.

14.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



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14.4. TEST RESULT

Test Point	Polarity	Test Level (kV)	Test Mode	Performance criteria
a.c. port, L	+/-	1	Mode 1/2	Α
a.c. port, N	+/-	1	Mode 1/2	Α
a.c. port, L-N	+/-	1	Mode 1/2	Α
a.c. port, L-N	+/-	1	Mode 1/2	Α

 $\ensuremath{\mathsf{A}}\xspace$ No degradation in the performance of the EUT was observed.

Note: operating mode include all modes of EMS in page 9.

14.5. PERFORMANCE

14.5. PERFORI	WANCE
⊠Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
□Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
	Not Compliance

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15. SURGE IMMUNITY TEST

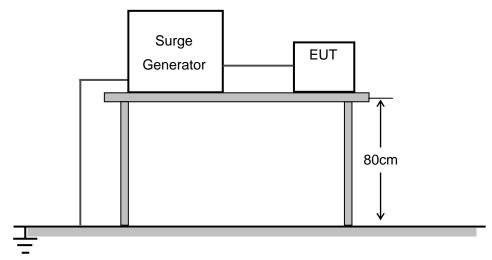
15.1. TEST SPECIFICATION

-				
Basic Standard	EN 61000-4-5			
Waveform	oltage 1.2/50 μs; Current 8/20 μs			
Test Voltage	a.c. power port, line to line 1.0 kV			
Polarity	Positive/Negative			
Phase Angle	0°, 90°, 180°, 270°			
Repetition Rate	60sec			
Times	5 time/each condition.			

15.2. TEST PROCEDURE

- a. The EUT and the auxiliary equipment were placed on a table of 0.8m heights above a metal ground reference plane. The size of ground plane is greater than 1m×1m and project beyond the EUT by at least 0.1m on all sides. The ground plane is connected to the protective earth. The length of power cord between the coupling device and the EUT was less than 2 meters (provided by the manufacturer).
- b. The EUT was connected to the power mains through a coupling device that directly couples the surge interference signal. The surge noise was applied synchronized to the voltage phase at the zero crossing and the peak value of the AC voltage wave (positive and negative).
- c. The surges were applied line to line and line(s) to earth. All lower levels including the selected test level were tested. The polarity of each surge level included positive and negative test pulses.

15.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



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15.4. TEST RESULT

Coupling Line	Polarity	Voltage (kV) Test Mode		Performance criteria	
a.c. power, L-N	Mode 1/2	А			
A: No degradation in the performance of the EUT was observed.					

Note: operating mode include all modes of EMS in page 9.

15.5. PERFORM	MANCE			
⊠Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.			
□Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.			
☐Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.			
☑ Compliance ☐ Not Compliance				

|--|



16. IMMUNITY TO CONDUCTED DISTURBANCES INDUCED BY RF FIELDS

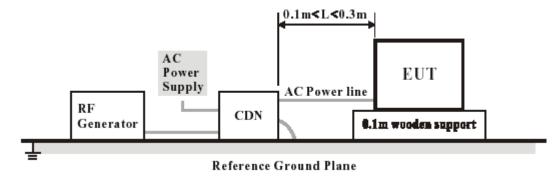
16.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-6		
Frequency Range	0.15 MHz – 80 MHz		
Field Strength	3Vrms		
Modulation	kHz Sine Wave, 80% AM		
Frequency Step	1% of fundamental		
Coupled Cable	a.c. power line		
Coupling Device	CDN-M2		

16.2. TEST PROCEDURE

- 1. The EUT shall be tested within its intended operating and climatic conditions.
- 2. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50-ohm load resistor.
- 3. The test signal was 80% amplitude modulated with a 1 kHz sine wave
- 4. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80% amplitude. The sweep rate shall not exceed 1.5×10-3 decades/s. The step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value where the frequency is swept incrementally.
- The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies such as clock frequencies and harmonics or frequencies of dominant interest, shall be analyzed separately.
- 6. Attempts should be made to fully exercise the EUT during test, and to fully interrogate all exercise modes selected for susceptibility.

16.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



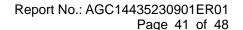
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16.4. TEST RESULT

Test Point	Frequency (MHz)	Level (V rms)	Test Mode	Performance criteria		
a.c. port 0.15 – 80		3	Mode 1/2	А		
A: No degradation in the performance of the EUT was observed.						

Note: operating mode include all modes of EMS in page 9.

16.5. PERFORM	MANCE
⊠Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
□Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
	- Not Committee
∠ Compliance	e





17. VOLTAGE DIPS AND SHORT INTERRUPTIONS IMMUNITY TEST

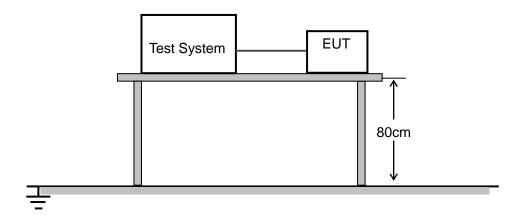
17.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-11		
	100% reduction, 0.5 Cycle		
Voltage Dips	100% reduction, 1.0 Cycle		
	30% reduction, 25 Cycles		
Voltage Interruptions 100% reduction, 250 Cycles			
Voltage Phase Angle 0°, 45°, 90°, 135°, 180°, 225°, 270°, 315°			

17.2. TEST PROCEDURE

- a). The power cord was used as supplied by the manufacturer. The EUT was connected to the line output of the Voltage Dips and Interruption Generator.
- b). The EUT was tested for (1) 100% voltage dip of supplied voltage with duration of 0.5 cycles, (2)100% voltage dip of supplied voltage and duration 1.0 cycle. (3) 30% voltage dip of supplied voltage and duration 25 cycles. (4) 100% voltage interruption of supplied voltage with duration of 250 Cycles was followed.
- c). Voltage reductions occur at 0 degree crossover point of the voltage waveform. The performance of the EUT was checked after the voltage dip or interruption.

17.3. TEST SETUP



For the actual test configuration, please refer to Appendix A, Photographs of the Test Configuration.



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17.4. TEST RESULT

Test Mode	Voltage Reduction	Duration (cycle)	Times	Interval (Sec)	Test Mode	Performance criteria
Voltage dips	100%	0.5	3	10	Mode 1/2	Α
	100%	1	3	10	Mode 1/2	А
	30%	25	3	10	Mode 1/2	А
Voltage interruptions	100%	250	3	10	Mode 1/2	В

A: No degradation in the performance of the EUT was observed.

B: Stop charging during the test and self-recoverable after test.

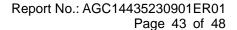
C: Lost functions can be recoverable by user or operator.

Note: operating mode include all modes of EMS in page 9.

17.5 PERFORMANCE

17.5. PERFURIMA	NCE
⊠Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
⊠Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

⊠ Compliance	☐ Not Compliance	
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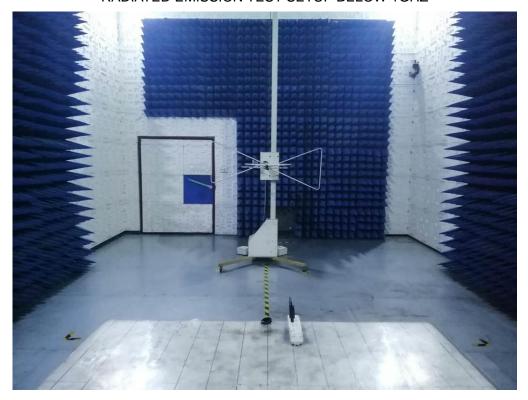


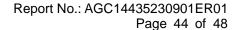
APPENDIX A: PHOTOGRAPHS OF TEST SETUP

LINE CONDUCTED EMISSION TEST SETUP



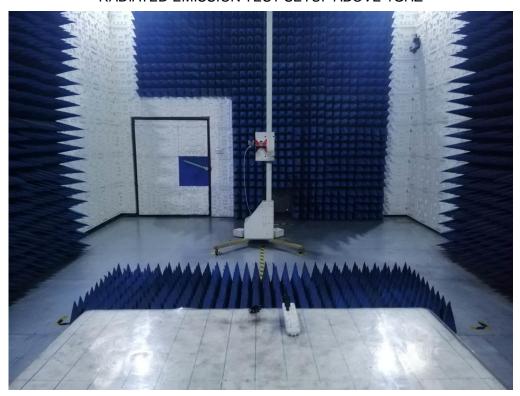
RADIATED EMISSION TEST SETUP BELOW 1GHZ





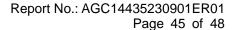


RADIATED EMISSION TEST SETUP ABOVE 1GHZ



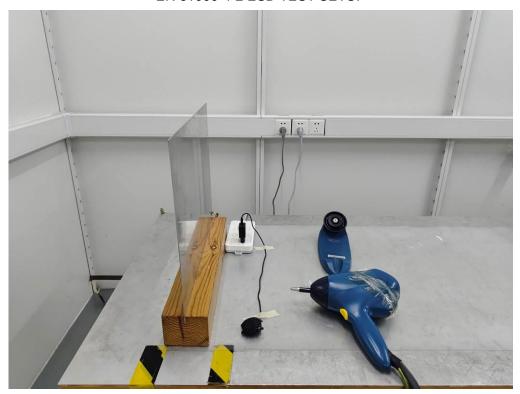
EN 61000-3-3 VOLTAGE FLUCTUATION / FLICKER TEST SETUP



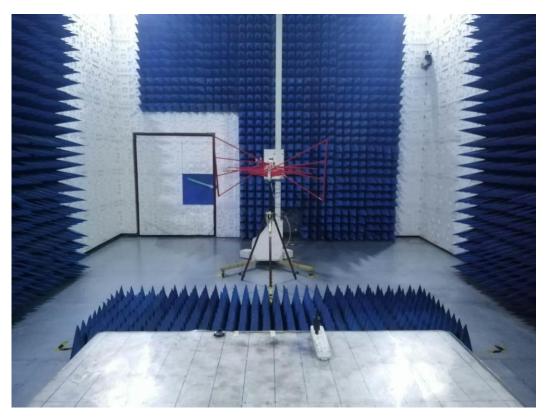


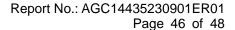


EN 61000-4-2 ESD TEST SETUP



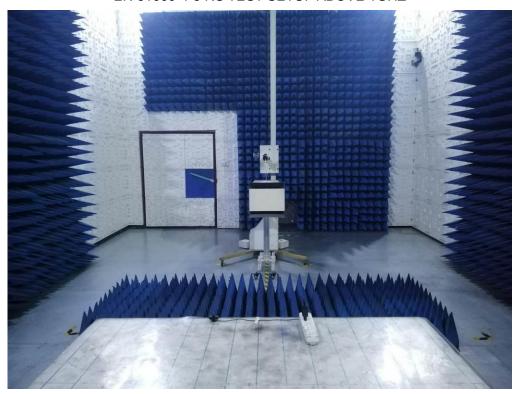
EN 61000-4-3 RS TEST SETUP BELOW 1GHZ





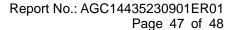


EN 61000-4-3 RS TEST SETUP ABOVE 1GHZ



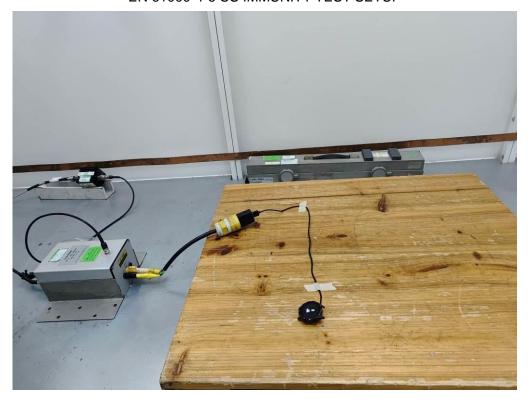
EN 61000-4-4/-5/-11 EFT/SURGE/DIPS IMMUNITY TEST SETUP







EN 61000-4-6 CS IMMUNITY TEST SETUP





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APPENDIX B: PHOTOGRAPHS OF EUT

Refer to the Report No.: AGC14435230901AP01

----END OF REPORT----



Conditions of Issuance of Test Reports

- 1. All samples and goods are accepted by the Attestation of Global Compliance (Shenzhen) Co., Ltd (the "Company") solely for testing and reporting in accordance with the following terms and conditions. The company provides its services on the basis that such terms and conditions constitute express agreement between the company and any person, firm or company requesting its services (the "Clients").
- 2. Any report issued by Company as a result of this application for testing services (the "Report") shall be issued in confidence to the Clients and the Report will be strictly treated as such by the Company. It may not be reproduced either in its entirety or in part and it may not be used for advertising or other unauthorized purposes without the written consent of the Company. The Clients to whom the Report is issued may, however, show or send it, or a certified copy thereof prepared by the Company to its customer, supplier or other persons directly concerned. The Company will not, without the consent of the Clients, enter into any discussion or correspondence with any third party concerning the contents of the Report, unless required by the relevant governmental authorities, laws or court orders.
- 3. The Company shall not be called or be liable to be called to give evidence or testimony on the Report in a court of law without its prior written consent, unless required by the relevant governmental authorities, laws or court orders.
- 4. In the event of the improper use of the report as determined by the Company, the Company reserves the right to withdraw it, and to adopt any other additional remedies which may be appropriate.
- 5. Samples submitted for testing are accepted on the understanding that the Report issued cannot form the basis of, or be the instrument for, any legal action against the Company.
- 6. The Company will not be liable for or accept responsibility for any loss or damage however arising from the use of information contained in any of its Reports or in any communication whatsoever about its said tests or investigations.
- 7.Clients wishing to use the Report in court proceedings or arbitration shall inform the Company to that effect prior to submitting the sample for testing.
- 8. The Company is not responsible for recalling the electronic version of the original report when any revision is made to them. The Client assumes the responsibility to providing the revised version to any interested party who uses them.
- 9. Subject to the variable length of retention time for test data and report stored hereinto as otherwise specifically required by individual accreditation authorities, the Company will only keep the supporting test data and information of the test report for a period of six years. The data and information will be disposed of after the aforementioned retention period has elapsed. Under no circumstances shall we provide any data and information which has been disposed of after retention period. Under no circumstances shall we be liable for damage of any kind, including (but not limited to) compensatory damages, lost profits, lost data, or any form of special, incidental, indirect, consequential or punitive damages of any kind, whether based on breach of contract of warranty, tort (including negligence), product liability or otherwise, even if we are informed in advance of the possibility of such damages.